

Notice of References Cited	Application/Control No. 10/729,058		Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,459,814	10-1995	Gupta et al.	704/233
*	C	US-6,708,146	03-2004	Sewall et al.	704/217
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*	L	US-6,978,235	12-2005	Ozawa, Kazunori	704/219
*	M	US-7,110,947	09-2006	Cox et al.	704/236

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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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